Search Notes

| Application/Control No. | Applicant(s)/Patent under Reexamination | | |
|-------------------------|---|---|--|
| 10/679,497 | INOUE, TETSUYOSHI | | |
| Examiner | Art Unit | _ | |
| Ernest Unelus | 2828 | | |

| SEARCHED | | | | | | | | |
|----------|----------|------|----------|--|--|--|--|--|
| Class | Subclass | Date | Examiner | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| - | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |
| | | | | | | | | |

| INI | ERFERENC | E SEARCH | IED |
|-------|----------|----------|----------|
| Class | Subclass | Date | Examiner |
| | | * | |
| | | | |
| | | | |
| | .1 | | |
| | | | |
| | | | |

| SEAF (INCLUDING S | RCH NOT | ES STRATEGY |) |
|----------------------|---------|----------------|------|
| | | DATE | EXMR |
| see attached | | 9/12/2005 | E.U |
| | | | |
| | | | |
| | | | |
| <u>,</u> | | | |
| | | | |
| | | | |
| | | | |
| | | | |